

FEATURES

Single Supply Operation
Low Supply Current: 700 μ A Max
Wide Gain Range: 1 to 1000
Low Offset Voltage: 150 μ V Max
Zero-In/Zero-Out
Single-Resistor Gain Set
8-Lead Mini-DIP and SO Packages

APPLICATIONS

Strain Gages
Thermocouples
RTDs
Battery-Powered Equipment
Medical Instrumentation
Data Acquisition Systems
PC-Based Instruments
Portable Instrumentation

GENERAL DESCRIPTION

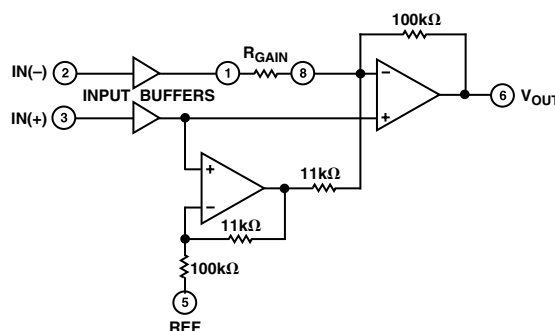
The AMP04 is a single-supply instrumentation amplifier designed to work over a +5 volt to ± 15 volt supply range. It offers an excellent combination of accuracy, low power consumption, wide input voltage range, and excellent gain performance.

Gain is set by a single external resistor and can be from 1 to 1000. Input common-mode voltage range allows the AMP04 to handle signals with full accuracy from ground to within 1 volt of the positive supply. And the output can swing to within 1 volt of the positive supply. Gain bandwidth is over 700 kHz. In addition to being easy to use, the AMP04 draws only 700 μ A of supply current.

For high resolution data acquisition systems, laser trimming of low drift thin-film resistors limits the input offset voltage to under 150 μ V, and allows the AMP04 to offer gain nonlinearity of 0.005% and a gain tempco of 30 ppm/ $^{\circ}$ C.

A proprietary input structure limits input offset currents to less than 5 nA with drift of only 8 pA/ $^{\circ}$ C, allowing direct connection of the AMP04 to high impedance transducers and other signal sources.

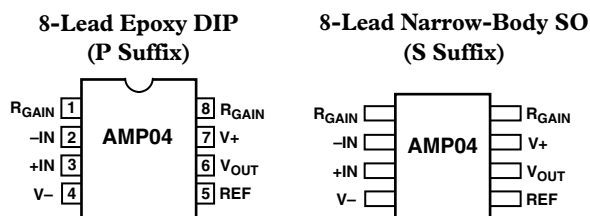
FUNCTIONAL BLOCK DIAGRAM



The AMP04 is specified over the extended industrial (-40° C to $+85^{\circ}$ C) temperature range. AMP04s are available in plastic and ceramic DIP plus SO-8 surface mount packages.

Contact your local sales office for MIL-STD-883 data sheet and availability.

PIN CONNECTIONS



*Protected by U.S. Patent No. 5,075,633.

REV. B

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AMP04—SPECIFICATIONS

ELECTRICAL CHARACTERISTICS

($V_S = 5\text{ V}$, $V_{CM} = 2.5\text{ V}$, $T_A = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Conditions	AMP04E			AMP04F			Unit
			Min	Typ	Max	Min	Typ	Max	
OFFSET VOLTAGE									
Input Offset Voltage	V _{IOS}	−40°C ≤ T _A ≤ +85°C		30	150			300	μV
Input Offset Voltage Drift	TCV _{IOS}					300			600
Output Offset Voltage	V _{OOS}	−40°C ≤ T _A ≤ +85°C		0.5	1.5			3	mV
Output Offset Voltage Drift	TCV _{OOS}					3			6
					30			50	μV/°C
INPUT CURRENT									
Input Bias Current	I _B	−40°C ≤ T _A ≤ +85°C		22	30			40	nA
Input Bias Current Drift	TCI _B					50			60
Input Offset Current	I _{OS}	−40°C ≤ T _A ≤ +85°C		65			65		pA/°C
Input Offset Current Drift	TCI _{OS}				1	5			10
					10			15	nA
				8			8		pA/°C
INPUT									
Common-Mode Input Resistance	V _{IN}	0 V ≤ V _{CM} ≤ 3.0 V		4			4		GΩ
Differential Input Resistance				4			4		GΩ
Input Voltage Range			0		3.0	0		3.0	V
Common-Mode Rejection			CMR	G = 1	60	80	55		dB
		G = 10	80	100	75		dB		
		G = 100	90	105	80		dB		
		G = 1000	90	105	80		dB		
Common-Mode Rejection	CMR	0 V ≤ V _{CM} ≤ 2.5 V							
		−40°C ≤ T _A ≤ +85°C							
		G = 1	55		50		dB		
		G = 10	75		70		dB		
		G = 100	85		75		dB		
		G = 1000	85		75		dB		
Power Supply Rejection	PSRR	4.0 V ≤ V _S ≤ 12 V							
		−40°C ≤ T _A ≤ +85°C							
		G = 1	95		85		dB		
		G = 10	105		95		dB		
		G = 100	105		95		dB		
		G = 1000	105		95		dB		
GAIN (G = 100 K/R _{GAIN})									
Gain Equation Accuracy	G	G = 1 to 100		0.2	0.5			0.75	%
		G = 1 to 100							
		−40°C ≤ T _A ≤ +85°C				0.8		1.0	%
		G = 1000		0.4			0.75		%
Gain Range	G	G = 1, R _L = 5 kΩ	1		1000	1		1000	V/V
Nonlinearity		G = 10, R _L = 5 kΩ		0.005					%
		G = 100, R _L = 5 kΩ		0.015					%
		G = 100, R _L = 5 kΩ		0.025					%
Gain Temperature Coefficient	ΔG/ΔT			30			50		ppm/°C
OUTPUT									
Output Voltage Swing High	V _{OH}	R _L = 2 kΩ	4.0	4.2		4.0			V
		R _L = 2 kΩ							
Output Voltage Swing Low	V _{OL}	−40°C ≤ T _A ≤ +85°C	3.8			3.8			V
		R _L = 2 kΩ							
		−40°C ≤ T _A ≤ +85°C			2.0			2.5	mV
Output Current Limit		Sink		30			30		mA
		Source		15			15		mA

Parameter	Symbol	Conditions	AMP04E			AMP04F			Unit
			Min	Typ	Max	Min	Typ	Max	
NOISE									
Noise Voltage Density, RTI	e_N	f = 1 kHz, G = 1		270			270		nV/ $\sqrt{\text{Hz}}$
		f = 1 kHz, G = 10		45			45		nV/ $\sqrt{\text{Hz}}$
		f = 100 Hz, G = 100		30			30		nV/ $\sqrt{\text{Hz}}$
		f = 100 Hz, G = 1000		25			25		nV/ $\sqrt{\text{Hz}}$
Noise Current Density, RTI	i_N	f = 100 Hz, G = 100		4			4		pA/ $\sqrt{\text{Hz}}$
Input Noise Voltage	e_N p-p	0.1 Hz to 10 Hz, G = 1		7			7		μV p-p
		0.1 Hz to 10 Hz, G = 10		1.5			1.5		μV p-p
		0.1 Hz to 10 Hz, G = 100		0.7			0.7		μV p-p
DYNAMIC RESPONSE									
Small Signal Bandwidth	BW	G = 1, -3 dB		300			300		kHz
POWER SUPPLY									
Supply Current	I_{SY}	$-40^{\circ}\text{C} \leq T_A \leq +85^{\circ}\text{C}$		550	700			700	μA
					850			850	μA

Specifications subject to change without notice.

ELECTRICAL CHARACTERISTICS ($V_S = \pm 15 \text{ V}$, $V_{CM} = 0 \text{ V}$, $T_A = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Conditions	AMP04E			AMP04F			Unit	
			Min	Typ	Max	Min	Typ	Max		
OFFSET VOLTAGE										
Input Offset Voltage	V _{IOS}	−40°C ≤ T _A ≤ +85°C	80	400			600	μV		
					600			900	μV	
Input Offset Voltage Drift	TCV _{IOS}			3			6	μV/°C		
Output Offset Voltage	V _{OOS}	−40°C ≤ T _A ≤ +85°C	1	3			6	mV		
					6			9	mV	
Output Offset Voltage Drift	TCV _{OOS}			30			50	μV/°C		
INPUT CURRENT										
Input Bias Current	I _B	−40°C ≤ T _A ≤ +85°C	17	30			40	nA		
					50			60	nA	
Input Bias Current Drift	TCI _B		65			65		pA/°C		
Input Offset Current	I _{OS}	−40°C ≤ T _A ≤ +85°C	2	5			10	nA		
					15			20	nA	
Input Offset Current Drift	TCI _{OS}		28			28		pA/°C		
INPUT										
Common-Mode Input Resistance	V _{IN} CMR	−12 V ≤ V _{CM} ≤ +12 V G = 1	4			4		GΩ		
Differential Input Resistance			4			4		GΩ		
Input Voltage Range			−12		+12	−12		+12	V	
Common-Mode Rejection			CMR	−11 V ≤ V _{CM} ≤ +11 V −40°C ≤ T _A ≤ +85°C G = 1	60	80		55		dB
					80	100		75		dB
		G = 100	90	105		80		dB		
		G = 1000	90	105		80		dB		
Common-Mode Rejection	CMR	−11 V ≤ V _{CM} ≤ +11 V −40°C ≤ T _A ≤ +85°C G = 1	55			50		dB		
			75			70		dB		
			85			75		dB		
			85			75		dB		
Power Supply Rejection	PSRR	±2.5 V ≤ V _S ≤ ±18 V −40°C ≤ T _A ≤ +85°C G = 1	75			70		dB		
			90			80		dB		
			95			85		dB		
			95			85		dB		

AMP04

Parameter	Symbol	Conditions	AMP04E			AMP04F			Unit
			Min	Typ	Max	Min	Typ	Max	
GAIN ($G = 100 \text{ K/R}_{\text{GAIN}}$)									
Gain Equation Accuracy		$G = 1 \text{ to } 100$		0.2	0.5			0.75	%
		$G = 1000$		0.4			0.75		%
		$G = 1 \text{ to } 100$			0.8			1.0	%
		$-40^{\circ}\text{C} \leq T_A \leq +85^{\circ}\text{C}$			1000			1000	V/V
Gain Range	G	$G = 1, R_L = 5 \text{ k}\Omega$	1	0.005		1	0.005		%
Nonlinearity		$G = 10, R_L = 5 \text{ k}\Omega$		0.015			0.015		%
		$G = 100, R_L = 5 \text{ k}\Omega$		0.025			0.025		%
Gain Temperature Coefficient	$\Delta G/\Delta T$			30			50		ppm/ $^{\circ}\text{C}$
OUTPUT									
Output Voltage Swing High	V_{OH}	$R_L = 2 \text{ k}\Omega$	13	13.4		13			V
		$R_L = 2 \text{ k}\Omega$							
		$-40^{\circ}\text{C} \leq T_A \leq +85^{\circ}\text{C}$	12.5			12.5			V
Output Voltage Swing Low	V_{OL}	$R_L = 2 \text{ k}\Omega$			-14.5			-14.5	V
		$-40^{\circ}\text{C} \leq T_A \leq +85^{\circ}\text{C}$							V
Output Current Limit		Sink		30			30		mA
		Source		15			15		mA
NOISE									
Noise Voltage Density, RTI	e_N	$f = 1 \text{ kHz}, G = 1$		270			270		$\text{nV}/\sqrt{\text{Hz}}$
		$f = 1 \text{ kHz}, G = 10$		45			45		$\text{nV}/\sqrt{\text{Hz}}$
		$f = 100 \text{ Hz}, G = 100$		30			30		$\text{nV}/\sqrt{\text{Hz}}$
		$f = 100 \text{ Hz}, G = 1000$		25			25		$\text{nV}/\sqrt{\text{Hz}}$
Noise Current Density, RTI	i_N	$f = 100 \text{ Hz}, G = 100$		4			4		$\text{pA}/\sqrt{\text{Hz}}$
Input Noise Voltage	$e_N \text{ p-p}$	$0.1 \text{ Hz to } 10 \text{ Hz}, G = 1$		5			5		$\mu\text{V p-p}$
		$0.1 \text{ Hz to } 10 \text{ Hz}, G = 10$		1			1		$\mu\text{V p-p}$
		$0.1 \text{ Hz to } 10 \text{ Hz}, G = 100$		0.5			0.5		$\mu\text{V p-p}$
DYNAMIC RESPONSE									
Small Signal Bandwidth	BW	$G = 1, -3 \text{ dB}$		700			700		kHz
POWER SUPPLY									
Supply Current	I_{SY}	$-40^{\circ}\text{C} \leq T_A \leq +85^{\circ}\text{C}$		750	900			900	μA
					1100			1100	μA

Specifications subject to change without notice.

WAFER TEST LIMITS ($V_S = 5 \text{ V}$, $V_{\text{CM}} = 2.5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Conditions	Limit	Unit
OFFSET VOLTAGE				
Input Offset Voltage	V_{IOS}		300	$\mu\text{V max}$
Output Offset Voltage	V_{OOS}		3	mV max
INPUT CURRENT				
Input Bias Current	I_B		40	nA max
Input Offset Current	I_{OS}		10	nA max
INPUT				
Common-Mode Rejection	CMR	$0 \text{ V} \leq V_{\text{CM}} \leq 3.0 \text{ V}$		
		$G = 1$	55	dB min
		$G = 10$	75	dB min
		$G = 100$	80	dB min
		$G = 1000$	80	dB min
Common-Mode Rejection	CMR	$V_S = \pm 15 \text{ V}, -12 \text{ V} \leq V_{\text{CM}} \leq +12 \text{ V}$		
		$G = 1$	55	dB min
		$G = 10$	75	dB min
		$G = 100$	80	dB min

Parameter	Symbol	Conditions	Limit	Unit
Power Supply Rejection	PSRR	$G = 1000$	80	dB min
		$4.0\text{ V} \leq V_S \leq 12\text{ V}$		
		$G = 1$	85	dB min
		$G = 10$	95	dB min
		$G = 100$	95	dB min
		$G = 1000$	95	dB min
GAIN ($G = 100\text{ K/R}_{\text{GAIN}}$) Gain Equation Accuracy		$G = 1\text{ to }100$	0.75	% max
OUTPUT				
Output Voltage Swing High	V_{OH}	$R_L = 2\text{ k}\Omega$	4.0	V min
Output Voltage Swing Low	V_{OL}	$R_L = 2\text{ k}\Omega$	2.5	mV max
POWER SUPPLY				
Supply Current	I_{SY}	$V_S = \pm 15$	900 700	$\mu\text{A max}$ $\mu\text{A max}$

NOTE

Electrical tests and wafer probe to the limits shown. Due to variations in assembly methods and normal yield loss, yield after packaging is not guaranteed for standard product dice. Consult factory to negotiate specifications based on dice lot qualifications through sample lot assembly and testing.

ABSOLUTE MAXIMUM RATINGS¹

Supply Voltage $\pm 18\text{ V}$
Common-Mode Input Voltage² $\pm 18\text{ V}$
Differential Input Voltage 36 V
Output Short-Circuit Duration to GND Indefinite
Storage Temperature Range
Z Package -65°C to $+175^\circ\text{C}$
P, S Package -65°C to $+150^\circ\text{C}$
Operating Temperature Range
AMP04A -55°C to $+125^\circ\text{C}$
AMP04E, F -40°C to $+85^\circ\text{C}$
Junction Temperature Range
Z Package -65°C to $+175^\circ\text{C}$
P, S Package -65°C to $+150^\circ\text{C}$
Lead Temperature Range (Soldering, 60 sec) 300°C

Package Type	θ_{JA}^3	θ_{JC}	Unit
8-Lead Cerdip (Z)	148	16	$^\circ\text{C/W}$
8-Lead Plastic DIP (P)	103	43	$^\circ\text{C/W}$
8-Lead SOIC (S)	158	43	$^\circ\text{C/W}$

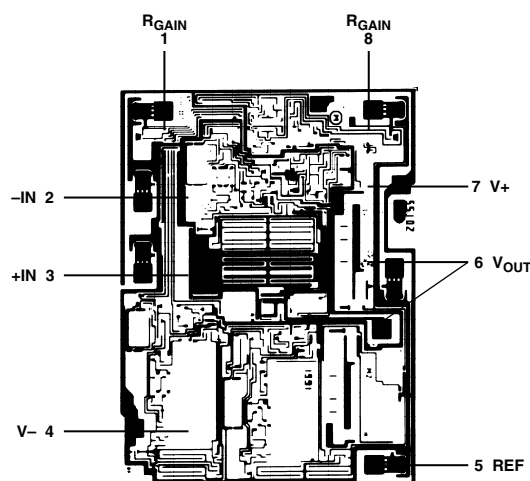
NOTES

¹Absolute maximum ratings apply to both DICE and packaged parts, unless otherwise noted.

²For supply voltages less than $\pm 18\text{ V}$, the absolute maximum input voltage is equal to the supply voltage.

³ θ_{JA} is specified for the worst case conditions, i.e., θ_{JA} is specified for device in socket for cerdip, P-DIP, and LCC packages; θ_{JA} is specified for device soldered in circuit board for SOIC package.

DICE CHARACTERISTICS



AMP04 Die Size $0.075 \times 0.99\text{ inch}$, 7,425 sq. mils.
Substrate (Die Backside) Is Connected to V_+ .
Transistor Count, 81.

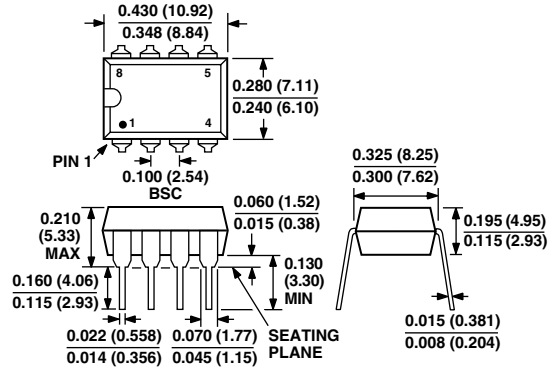
ORDERING GUIDE

Model	Temperature Range	V_{OS} @ 5 V $T_A = 25^\circ\text{C}$	Package Description	Package Option
AMP04EP	XIND	150 μV	Plastic DIP	N-8
AMP04ES	XIND	150 μV	SOIC	SO-8
AMP04ES-REEL7	XIND	150 μV	SOIC	SO-8
AMP04FP	XIND	300 μV	Plastic DIP	N-8
AMP04FS	XIND	300 μV	SOIC	SO-8
AMP04FS-REEL	XIND	150 μV	SOIC	SO-8
AMP04FS-REEL7	XIND	150 μV	SOIC	SO-8
AMP04GBC	25°C	300 μV		

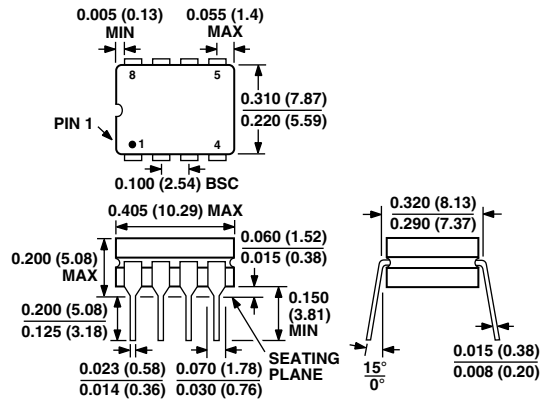
OUTLINE DIMENSIONS

Dimensions shown in inches and (mm).

8-Lead Plastic DIP (N-8)



8-Lead Cerdip (Q-8)



8-Lead Narrow-Body SO (SO-8)

